

**Search Notes**

Application/Control No.

10/050,101

Examiner

John Chavis

Applicant(s)/Patent under  
Reexamination

NAKANO, MINORU

Art Unit

2191

**SEARCHED**

Class	Subclass	Date	Examiner
717	174	7/21/2005	JC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West (IBM TDB, DERWENT, EPO, JPO, USPAT, PGPUBS)	7/21/2005	JC